# Free-standing graphene oxide/oxidized carbon nanotube films with mixed proton and electron conductor properties 

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Figure S1: C1s XPS spectra of SWCNT and Ox-SWCNT


Figure S2: FT-IR spectra of SWCNT and Ox-SWCNT


Figure S3: SEM image of GO/Ox-SWCNT representing the distribution of GO and OxSWCNT and demonstrates the attachment of Ox-SWCNT to GO


Figure S4: SEM image of GO/Ox-SWCNT (a) before and (b) after the bending of film


Figure S5: Representative cole-cole plot of of GO/Ox-SWCNT depending on RH at room temperature.


Figure S6: I-V plot of pristine SWCNT measured in the in-plane direction at room temperature and $50 \% \mathrm{RH}$ for measurement of electrical conductivity in the out of plane direction.

